Voltage Stability Margin (VSM) and Maximum Loading Point (MLP) Of A Multi-Bus System Before and After Compensation

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Abstract:- The purpose of this paper is to study the reactive power sensitivity as an index for finding out the weakest bus. Voltage Collapse point is also determined from the P-V and Q-V curves of the weakest and next weakest bus. The way of finding out Voltage Stability Margin is also proposed. Finally, a method to compensate the reactive power of the weakest bus to improve its stability is also proposed. Contingency test is also carried out to study at which condition the system is more secured. These techniques are tested on the IEEE-14 bus system and results are given to prove the effectiveness of the proposed methods.

Keywords:- Voltage Stability Margin (VSM), Voltage Collapse Point, $(\partial Q/\partial V)$ indicator, Maximum Loading Point (MLP), Contingency.

I. INTRODUCTION

THE increase in power demand and limited sources for electric power has resulted in an increasingly complex interconnected system, forced to operate closer to the limits of stability. Voltage instability is mainly associated with reactive power imbalance. The loadability of a bus in the power system depends on the reactive power support that the bus can receive from the system as the system approaches the voltage collapse point or maximum loading point (MLP). Voltage collapse phenomena in power systems have become one of the important concerns in the power industry over the last two decades, as this has been the major reason for several major blackouts that have occurred throughout the world. Hence, the ability to determine voltage stability before voltage collapse has received a great attention. The only way to save the system from voltage collapse is to reduce the reactive power load or add additional reactive power prior to reaching the point of voltage collapse.

'Voltage stability' is concerned with the ability of power system to maintain the steady acceptable voltages at all system buses under normal conditions as well as when the system is being subjected to a disturbance [13]. Power system is voltage stable if voltages after a disturbance are close to voltages at normal operating condition. A power system becomes unstable when voltage uncontrollably decreases due to outage of equipment, increment of load, decrement of production. There are two types of voltage stability based on the time frame of simulation: static voltage stability and dynamic voltage stability. Static analysis involves only the solution of algebraic equations and hence is computationally less extensive than dynamic analysis. Static voltage stability is ideal for the bulk of studies in which voltage stability limit for many cases must be determined. **'Voltage Security'** is basically related to a degree of minimal probability of blackout and equipment damage [13].

In this work an IEEE standard 14 bus systems is considered and the weakest bus is found out using Newton Raphson Load Flow analysis method and also the weakest bus is compensated by connecting a shunt capacitor to this bus. The after effect on the other buses is also considered.

Voltage Stability Margin (VSM) of the weakest bus as well as of the next weakest bus is calculated for checking the security level of these buses. Voltage Stability Margin (VSM) is the measure of the security level of the bus, if the value of VSM is high then the bus is more secured and vice versa.

"Contingency Analysis" is an essential part of the security analysis. Contingency arises due to scheduled outage, component switching, or unscheduled outage due to fault. Contingency test is also carried out on the weakest bus of the IEEE standard 14 bus system and it is checked out at which condition the bus is more secured [1].

The investigation reveals that it is possible to identify the weakest load bus in any multi bus system and it is possible to compute the voltage stability margin at that load bus using the developed technique. Compensation is also done by connecting fixed capacitor with the weakest bus.

II. DETERMINATION OF THE WEAKEST LOAD BUS VOLTAGE COLLAPSE POINT AND VOLTAGE STABILITY MARGIN (VSM)

Newton-Raphson Load Flow analysis is carried out on the IEEE-14 bus system. The basic equation used in Newton-Raphson method is-

Thus, Jacobian Matrix (equation 1) is formed. Jacobian matrix (J) can be subdivided into four sub matrices- J= [J1 J2; J3 J4].

Now, the reactive power is less sensitive to changes in phase angles and is mainly dependent on changes in voltage magnitudes. Similarly, real power change is less sensitive to the change in the voltage magnitude and is most sensitive to the change in phase angle. So, it is quite accurate to set J2 and J3 of the Jacobian matrix to zero.

The diagonal elements of J4 indicate the reactive power sensitivity of i-th bus. $\partial Qi/\partial |Vi|$ also indicates the degree of weakness for the i-th bus. The bus corresponding to the maximum value of $\partial Qi/\partial |Vi|$ is the strongest bus and the bus corresponding to the minimum value of $\partial Qi/\partial |Vi|$ is the weakest bus [1]. In this way weakest load bus of any multi bus system can be found out.

In static voltage stability, slowly developing changes in the power system occur that eventually lead to a shortage of reactive power and declining voltage. This phenomenon can be seen from the plot of power transferred versus the voltage at receiving end. The plots are popularly referred to as P-V curve or "Nose" curve. It is seen that as the power transfer increases, the voltage is decreased (keeping reactive power constant). Similarly, Q-V curve can be obtained by keeping P constant and gradually increasing the reactive power (Q). Now, identification of voltage collapse point is obtained using this conventional P-V and Q-V curves. There is a critical point beyond which there is no load flow solution and the load flow method will not converge. Such a load point represents the "knee" point of the P-V and Q-V curve. This is the point at which the voltage collapse occurs.

"Voltage Stability Margin" of a power system is a measure to estimate the available power transfer capacity, net power transfer capacity or total power transfer capacity. Voltage stability margin (VSM) is the measure of the security level of the bus, if the value VSM is high then the bus is more secured and vice versa [1]. Voltage stability margin (VSM) is a straightforward, widely accepted and easily understood index of voltage collapse.

This is a difference or a ratio between the operation and voltage collapse points according to a key parameter (loading, line flow, etc). So, voltage stability margin can be calculated in the following manner-

In equation 2, $V_{W\ (base)}$ = bus voltage of the weakest bus of the system at normal operating condition.

 $V_{W(critical)}$ = bus voltage of the weakest bus of the system at voltage collapse point.



III. SIMULATION AND RESULTS

Fig-1 shows the IEEE standard 14 bus system.

Newton Raphson Load Flow Method is applied on this system. The diagonal elements of J4 matrix as obtained in the test is given in the table-1 below-

Load	Table 1: Diagonal Elements of Diagonal Elements of J4	System Bus No.
Bus	6	5
No.		
1	32.9706	4
2	28.6156	5
3	18.5629	7
4	22.5711	9
5	13.8719	10
6	8.2876	11
7	5.4054	12
8	10.4986	13
9	4.9687	14

Table 1: D	iagonal Element	s of J4 Matrix
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So, for IEEE standard 14 bus system the weakest bus is 14th bus and the next weakest bus is 12th bus without the connection of any compensating device.

IV. DETERMINATION OF VOLTAGE STABILITY MARGIN (VSM) OF THE WEAKEST BUS AND NEXT WEAKEST BUS WITHOUT ANY COMPENSATION

Now, the voltage collapse point is determined, P is increased keeping Q constant and P-V curve is plotted for the weakest and next weakest bus. Also Q is increased keeping P constant and Q-V curve is plotted for the weakest bus and next weakest bus. The P-V and Q-V curve of the weakest and next weakest bus is shown in the fig-2(a), fig-2(b), fig-2(c) and fig-2(d).





Fig-2(d): Q-V profile of the next weakest bus (12th bus)

For IEEE standard 14 bus system the Voltage stability margin as obtained in our test is shown in the table below-

Table 2:	VSM of	12^{TH} and	14^{TH} bus
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Bus No.	VSM(P)	VSM(Q)
12(Next Weakest Bus)	0.1154	0.8806
14 (Weakest Bus)	0.2379	0.8873

V. CONNECTION OF REACTIVE POWER COMPENSATING DEVICE TO THE WEAKEST BUS

Now inspection of the system is done by connecting a capacitor of 97.78uF in between the weakest bus and ground thus increasing the shunt charging admittance (Fixed capacitor modeling). The diagonal elements of J4 become as per table 3.

Table 3: Diagonal Elements of J4 Matrix (After Compensation)		
Load	Diagonal Elements of J4	System Bus No.
Bus No.		
1	34.8920	4
2	29.5384	5
3	23.1008	7
4	30.6101	9
5	18.9546	10
6	9.7780	11
7	5.8352	12
8	12.0663	13
9	6.0877	14
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 Table 3: Diagonal Elements of J4 Matrix (After Compensation)

Now, it is seen that bus no 12 is now the weakest bus and bus no 14 is the next weakest bus. For the sake of comparison the P-V and Q-V profile of the compensated and uncompensated 14th bus is shown in the figure below where the P-V profile is shown in fig-3(a) and the Q-V profile is shown in fig-3(b).



Fig-3(a): P-V profile of the 14th bus with and without compensation



Fig-3(b): Q-V profile of the 14th bus with and without compensation

The change in the voltage stability margin (VSM) with the addition of shunt capacitor is shown in the table-4 below-

Bus No.	VSM(P)	VSM(Q)
12(Weakest Bus)	0.2379	0.8873
14 (Next Weakest Bus)	0.1905	0.7853

VI. CONTINGENCY TEST

Contingency test have been done on 14th bus (weakest bus) by tripping the line connected to it and corresponding VSM is calculated.

CASE-1 (TRIPPING LINE 13-14)

• Line connecting the bus 13 and 14 is tripped. Now keeping Q constant, P is increased of the 14th bus and corresponding value of V is noted. VSM (P) is calculated.

• Now, keeping P constant, Q of the 14th bus is increased and the corresponding V is noted. VSM (Q) is calculated.

VSM(P)	VSM(Q)
0.5827	0.9147

CASE-2 (TRIPPING LINE 9-14)

• Line connecting the bus 9 and 14 is tripped. Now keeping Q constant, P is increased of the 14th bus and corresponding value of V is noted. VSM (P) is calculated.

• Now, keeping P constant, Q of the 14th bus is increased and the corresponding V is noted. VSM (Q) is calculated.

VSM(P)	VSM(Q)
0.5285	0.8509

Now, voltage stability margin (VSM) is the measure of the security level of the bus, if the value of VSM is high then the bus is more secured and vice-versa [1].

In case -1, i.e. when the line connecting 13 and 14 bus is tripped then the value of VSM is higher than the other two cases (tripping line 9-14 and no trip condition), that means in that case bus number 14 is more secured.

VII. CONCLUSION

If we compare the status of compensated and uncompensated 14th bus it is seen that the power transfer capability of the bus has been increased after the addition of shunt capacitor. The comparison can best be done with help of the graph showing the P-V curve of the uncompensated 14th bus and the graph showing the P-V curve of the compensated 14th bus. The active power at which the voltage collapse occur is larger in case of

compensated 14th bus than the uncompensated 14th bus, i.e., the maximum loading point (MLP) is increased after compensation.

Also, if we compare the graph showing the Q-V curve of the uncompensated 14th bus with the graph showing the Q-V curve of the compensated 14th bus, it seen that the reactive power at which the voltage collapse occur is larger in case of compensated 14th bus than the uncompensated 14th bus.

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